Sheet 1 of 2 INFORMATION DISCLOSURE STATEMENT FFB 0 8 2008 FORM PTO 1449 (modified) SERIAL NO ATTY DOCKET NO. 2006 1166A 10/590 111 U.S. DEPARTMENT OF COMMENCE PATENT AND THE PENARTH FICE APPLICANT Yasumichi FUKUDA et al. LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) FILING DATE GROUP Date Submitted to PTO: February 8, 2008 1614 May 14, 2007 U.S. PATENT DOCUMENTS *FXAMINER DOCUMENT DATE NAME CLASS SUBCLASS FILING DATE IF INITIAL NUMBER APPROPRIATE /SY/ AA 5,939,560 8/1999 Jenkins et al. AB 6.201.132 3/2001 Jenkins et al. AC 6,166,063 12/2000 Villhauer 2004/0106655 AD 6/2004 Kitajima et al. 2005/0245538 11/2005 Kitajima et al. AF 2006/0173056 8/2006 Kitajima et al. 3/2005 AG 2005/0054678 Yasuda et al. AΗ 2006/0241146 10/2006 Yasuda et al. ΑI 2004/0072892 4/2004 Fukushima et al. 2007/0112059 5/2007 Fukushima et al. ΔK 2007/0112205 5/2007 Fukushima et al. ΑJ 2004/0167341 8/2004 Haffner et al. 2004/0171848 9/2004 Haffner et al. FOREIGN PATENT DOCUMENTS CLASS SUBCLASS DOCUMENT DATE COUNTRY TRANSLATION NUMBER YES NO /SY/ BA 98/19998 5/1998 wo /SY/ BB 2004/007446 1/2004 wo BC: OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) CA International Search Report issued March 29, 2005 in the International (PCT) Application /SY/ PCT/2005/002389 of which the present application is the U.S. National Stage. CB International Preliminary Report on Patentability issued September 19, 2006 in the International (PCT) /SY/ Application PCT/2005/002389 of which the present application is the U.S. National Stage. **EXAMINER** DATE CONSIDERED

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